

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/812,526	LEE ET AL.
	Examiner	Art Unit
	David J. Makiya	2875

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Keyword search in EAST: (see attached)	9/6/2005	DJM
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner